

Search Notes

Application/Control No.

10/551,719

Examiner

Tam Nguyen

Applicant(s)/Patent under
Reexamination

CHAE, HEE-SEON

Art Unit

3764

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|-------------------------------------|-----------|----------|
| 482 | 51-53,62, 70,73,79, 95,96,131 | 7/24/2006 | TN |
| 482 | 136,142 | 7/24/2006 | TN |
| 482 | 146,147 | 7/24/2006 | TN |
| D21 | 688,689 | 7/24/2006 | TN |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|-----------|----------|
| 482 | 51,146 | 7/24/2006 | TN |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|------------------------------------|-----------|------|
| Interference Search History Report | 7/24/2006 | TN |
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